

S/N: 10/551,035



8/3/2006

Docket No.: ANDO-023-PCT

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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Serial No.: 10/551,035

Confirmation No.: 4025

Applicant: Yasushi SANO et al.

Art Unit: 1742

Filed: September 27, 2005

Examiner: TO BE ASSIGNED

Docket No: ANDO-023-PCT

Customer No: 28892

For: Electrolytic Copper Foil With Low Roughness Surface and
Process for Producing the Same

INFORMATION DISCLOSURE STATEMENT
PURSUANT TO 37 C.F.R. §§ 1.56, 1.97, and 1.98

US Patent & Trademark Office
Customer Service Window
Randolph Building
401 Dulany Street
Alexandria, VA 22314

Sir:

In compliance with the dictates of 37 C.F.R. §§ 1.56, 1.97, and 1.98, Applicant hereby submits an Information Disclosure Statement.

Applicant hereby reports the issuance of a Search Report in the corresponding application. A copy of that Search Report and the references cited therein, together with PTO Form 1449 listing each of the references submitted is attached hereto.

Please note that in three instances the Search Report cited a US patent document and the Japanese foreign priority document (US Patent # 5,834,140 and its equivalent JP 9-143784, US Patent # 5,863,410 and its equivalent JP 2002-506484 and US patent

INFORMATION DISCLOSURE STATEMENT TRANSMITTAL - PAGE 2

application 2003-102209 and its equivalent JP 9-143784). Applicant herein submits the Japanese Patent Office documents. In accordance with MPEP § 609 III A(2), copies of US patent documents are not attached for applications filed after June 30, 2003 (MPEP Rev. 2, May 2004, page 600-128).

It is respectfully requested that the Examiner consider each of these references and indicate such consideration by enclosing an appropriately initialled copy of the enclosed form PTO-1449 with the next communication from the Patent Office.

Respectfully submitted,



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Date: August 3, 2006

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INFORMATION DISCLOSURE STATEMENT - PTO FORM 1449

| U.S. PATENT DOCUMENTS | | | |
|-----------------------|-----------------------------|---|--|
| Examiner Initials* | U.S. Patent Document Number | Name of Patentee or Applicant of Cited Document | Date of Publication of Cited Document MM-DD-YYYY |
| | 2003/0102209 A1 | Fumiaki Hosokoshi et al. | 06-05-2003 |
| | 5,863,410 | Charles B. Yates et al. | 01-26-1999 |
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| Examiner Initials* | Foreign Patent Document Number | Name of Patentee or Applicant of Cited Document | Date of Publication of Cited Document MM-DD-YYYY | T** |
| | JP 2002-294481 w/ English Abstract | Mitsui Mining & Smelting Co., Ltd. | 10-09-2002 | |
| | JP 2002506484 (US Pat 5,863,410) | Circuit Foil USA, Inc. | 2-26-2006 | |
| | JP 2002-053992 w/ English Abstract | Permelec Electrode Ltd. Circuit Foil Taiwan Corp. | 02-19-2002 | |
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| | JP 9-143785 (US Pat 5,834,140) | Furukawa Circuit Foil KK | 06-03-1997 | |
| | JP 9-143784 (US2003/0102209) | Furukawa Electric Co., Ltd. | 06-03-1997 | |

S/N: 10/551,035

8/3/2006

Docket No.: ANDO-023-PCT



INFORMATION DISCLOSURE STATEMENT - PTO FORM 1449 - Page 2 of 2

OTHER PRIOR ART - NON PATENT LITERATURE DOCUMENTS

| | | |
|---------------------|--|-----|
| Examiners Initials* | Include Author (CAPITAL LETTERS), title of article, book, magazine, etc. date, page(s), volume-issue number(s), publisher, city and/or country where published | T** |
| | Japan Industrial Standard, Z 8741 - 1997, "Specular glossiness - Methods of Measurement", pp. 1 - 18 | |
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|--------------------|--|-----------------|--|
| Examiner Signature | | Date Considered | |
|--------------------|--|-----------------|--|

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

**Applicant is to place a check mark here if English language translation is attached